Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

CHOWN, DAVID

Examiner

10622294

Liu, Li

Art Unit 2613

Notes	Date	Examiner	
EAST	-		
USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	08/03/2006	LL	
Google	08/03/20063	LL	
IEEE	08/03/2006	LL	
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Class	SubClass	Date		Examiner
372	102	08/03/2006	LL	
398	152, 129, 58, 122, 125	08/03/2006	LL	
385	12, 93, 49	08/03/2006	LL	
250	25	08/03/2006	LL	